

1 We claim:

2 1. A method of forming a raised solder mass used to electrically interconnect a first substrate to a
3 second substrate in order to reduce current density for current flowing within such raised solder
4 mass, the method comprising the steps of:

5 a. providing a first substrate, said first substrate having at least one electrical contact upon an
6 upper surface thereof;

7 b. forming a solder bar upon the upper surface of said first substrate, the solder bar being
8 electrically-coupled to the at least one electrical contact with for joining said at least one electrical
9 contact to a second electrical contact on a second substrate, said step of forming the solder bar
10 including the further steps of:

11 i. forming first and second generally circular solder pads each of a first predetermined
12 diameter D upon the first substrate, each of the first and second generally circular solder pads
13 having a center, and spacing the centers of the first and second generally circular solder pads
14 at a predetermined spacing distance BL from each other;

15 ii. forming a bar pad of a first predetermined bar width BW upon the first substrate
16 connecting the first circular solder pad to the second circular solder pad, the first
17 predetermined bar width BW being less than the first predetermined diameter D;

18 iii. forming a predetermined solder bar volume VB over the first and second generally
19 circular solder pads and over the bar pad, the solder bar volume VB reaching a height H1
20 above the centers of the first and second generally circular solder pads, and reaching a height
21 H2 above a midpoint of the bar pad; and

22 iv. selecting predetermined diameter D, spacing distance BL, predetermined bar width
23 BW and solder bar volume VB in such manner that H1 and H2 are approximately equal.

25 2. The method recited by claim 1 including the further step of forming conventional generally

26 circular (as viewed from above) solder bumps upon the upper surface of the first substrate, the

27 conventional generally circular solder bumps having a height H3, and wherein height H1 and height

28 H2 of the solder bar are approximately equal to height H3.

1 3. The method recited by claim 2 wherein the conventional generally circular solder bumps have a
2 particular solder pad diameter D_c , and wherein the diameter D of the first and second generally
3 circular solder pads of the solder bar is in the range of from substantially D_c to substantially 2 times
4 D_c .
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6 4. The method recited by claim 2 wherein the conventional generally circular solder bumps have a
7 particular solder bump volume V_c , and wherein the solder bar volume V_B is in the range of from
8 substantially 2 times V_c to substantially 5 times V_c .
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10 5. The method recited by claim 1 wherein the volume of solder bar volume V_B , the spacing distance
11 BL , and bar width BW are preselected, and wherein the step of forming the solder bar includes the
12 steps of:
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- 13 a. selecting an initial value of diameter D ;
- 14 b. computing values for H_1 and H_2 based upon the preselected values for V_B , BL , BW , and
the initial value for D ;
- 16 c. reducing diameter D if the result of step b. is that H_1 is greater than H_2 , and increasing
diameter D if the result of step b. is that H_1 is less than H_2 ;
- 18 d. repeating steps b. and c. in an iterative process until the computed value of H_1 becomes
approximately equal to the computed value of H_2 ; and
- 20 e. using the value for diameter D determined by step d. to form the first and second generally
21 circular solder pads of the solder bar.

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23 6. The method recited by claim 5 wherein computing step b. is performed by a computer running
24 computer software that implements a regression algorithm.
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26 7. The method recited by claim 1 wherein the diameter D , the spacing distance BL , and bar width
27 BW are preselected, and wherein the step of forming the solder bar includes the steps of:
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1 a. selecting an initial value of solder bar Volume VB;

2 b. computing values for H1 and H2 based upon the preselected values for D, BL, BW, and

3 the initial value for VB;

4 c. changing solder bar volume VB, repeating step b., and determining whether such change in

5 solder volume VB decreases the difference between the computed values for H1 and H2;

6 d. repeating steps b. and c. in an iterative process until the computed value of H1 becomes

7 approximately equal to the computed value of H2; and

8 e. using the value for solder bar volume VB determined by step d. to form the solder bar.

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10 8. The method recited by claim 7 wherein computing step b. is performed by a computer running

11 computer software that implements a regression algorithm.

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13 9. The method recited by claim 1 wherein the first substrate is a flip-chip integrated circuit.

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15 10. The method recited by claim 1 wherein any difference between height H2 and height H1 is less

16 than 10% of height H2.

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18 11. The method recited by claim 10 wherein any difference between height H2 and height H1 is less

19 than 5% of height H2.

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21 12. The method recited by claim 1 wherein the diameter D, the spacing distance BL, and the solder

22 bar volume VB are preselected, and wherein the step of forming the solder bar includes the steps of:

23 a. selecting an initial value of bar width BW;

24 b. computing values for H1 and H2 based upon the preselected values for D, BL, VB, and the

25 initial value for BW;

26 c. reducing bar width BW if the result of step b. is that H1 is greater than H2, and increasing

27 bar width BW if the result of step b. is that H1 is less than H2;

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1 d. repeating steps b. and c. in an iterative process until the computed value of H1 becomes
2 approximately equal to the computed value of H2; and
3 e. using the value for bar width BW determined by step d. to form the bar pad of the solder
4 bar.

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6 13. The method recited by claim 12 wherein computing step b. is performed by a computer running
7 computer software that implements a regression algorithm.

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9 14. The method recited by claim 1 wherein the diameter D, the bar width BW, and the solder bar
10 volume VB are preselected, and wherein the step of forming the solder bar includes the steps of:
11 a. selecting an initial value of spacing distance BL;
12 b. computing values for H1 and H2 based upon the preselected values for D, BW, VB, and
13 the initial value for BL;
14 c. increasing spacing distance BL if the result of step b. is that H1 is greater than H2, and
15 decreasing spacing distance BL if the result of step b. is that H1 is less than H2;
16 d. repeating steps b. and c. in an iterative process until the computed value of H1 becomes
17 approximately equal to the computed value of H2; and
18 e. using the value for spacing distance BL determined by step d. to form the bar pad of the
19 solder bar.

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21 15. The method recited by claim 14 wherein computing step b. is performed by a computer running
22 computer software that implements a regression algorithm.

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24 16. A solder bar formed upon an upper surface of a first substrate, the first substrate having a first
25 electrical contact, said solder bar being adapted to join the first electrical contact to a second
26 electrical contact on a second substrate, said solder bar comprising in combination:
27 a. a first generally circular solder pad formed upon the upper surface of the first substrate, the
28 first generally circular solder pad having a center, and having a first predetermined diameter D;

1 b. a second generally circular solder pad formed upon the upper surface of the first substrate,
2 the second generally circular solder pad having a center, and having said first predetermined
3 diameter D, the center of said second generally circular solder pad being spaced from the center of
4 said first generally circular solder pad by a predetermined spacing distance BL;

5 c. a solder bar pad of a first predetermined bar width BW formed upon the upper surface of
6 the first substrate connecting said first circular solder pad to said second circular solder pad, the first
7 predetermined bar width BW being less than the first predetermined diameter D;

8 d. a mass of solder having a solder bar volume VB formed over the first and second generally
9 circular solder pads and over said solder bar pad to form said solder bar, the solder bar volume VB
10 reaching a height H1 above the centers of said first and second generally circular solder pads, and
11 reaching a height H2 above a midpoint of said solder bar pad;

12 e. wherein the values for predetermined diameter D, spacing distance BL, predetermined bar
13 width BW, and solder bar volume VB are selected in such manner that H1 and H2 are approximately
14 equal.

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16 17. The apparatus recited by claim 16 wherein conventional generally circular (as viewed from
17 above) solder bumps are also formed upon the upper surface of the first substrate, the conventional
18 generally circular solder bumps having a height H3, and wherein height H1 and height H2 of said
19 solder bar are approximately equal to height H3.

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21 18. The apparatus recited by claim 17 wherein the conventional generally circular solder bumps
22 have a particular solder pad diameter Dc, and wherein the diameter D of said first and second
23 generally circular solder pads of said solder bar is in the range of from substantially Dc to
24 substantially 2 times Dc.

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26 19. The apparatus recited by claim 17 wherein the conventional generally circular solder bumps
27 have a particular solder bump volume Vc, and wherein the solder bar volume VB is in the range of
28 from substantially 2 times Vc to substantially 5 times Vc.

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1 20. The apparatus recited by claim 16 wherein said first substrate is a flip-chip integrated circuit.

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3 21. The apparatus recited by claim 16 wherein any difference between height H2 and height H1 is

4 less than 10% of height H2.

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6 22. The apparatus recited by claim 16 wherein any difference between height H2 and height H1 is

7 less than 5% of height H2.

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